

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned
Examiner: To Be Assigned

In re PATENT APPLICATION of

Applicant(s) : Motoki KOBAYASHI et al.

Appln. No. : To Be Assigned

Filed : September 30, 2003

For : SEMICONDUCTOR DEVICE AND
SEMICONDUCTOR DEVICE
FABRICATION METHOD

Atty. Dkt. : FUJI 137

**INFORMATION
DISCLOSURE
STATEMENT**

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

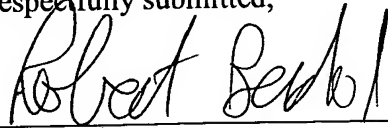
Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

Attached are copies of four Japanese patent publications. Any relevance of the publications can be gleaned from the attached English-language Abstracts. The publications are listed on the attached Form PTO-1449.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the documents submitted. Consideration of the submitted documents is respectfully requested.

Respectfully submitted,



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RHB:tz

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty Docket		Application No.	
				FUJI 137		To Be Assigned	
				Applicant			
				Motoki KOBAYASHI and Fumio ICHIKAWA			
Filing Date				Group Unit			
September 30, 2003				To Be Assigned			
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AL						
	AF						
	AG						
	AH						
	AI						
	AJ						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation
	AK	2001-308667	11/02/01	Japan			Abstract
	AL	10-135487	05/22/98	Japan			Abstract
	AM	10-098200	04/14/98	Japan			Abstract
	AN	09-270515	10/14/97	Japan			Abstract
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AO						
	AP						
	AQ						
	AR						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							